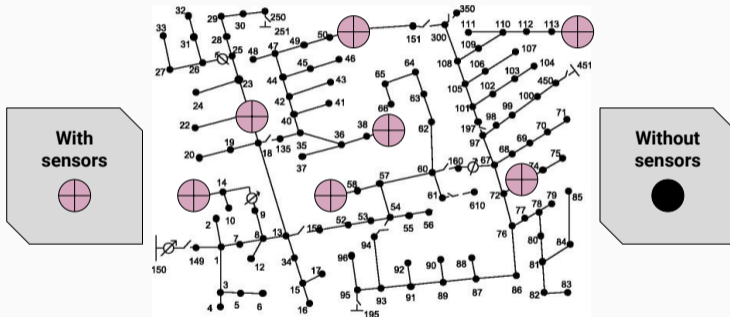


Strategic distribution network sensing

Samuel Talkington, Rahul Gupta, Richard Asiamah,
Paprapee Buason, Daniel K Molzahn

December 2024

Traditional sensor placement: offline, static



Select *locations* (a subset of nodes) to
install sensors and *measure continuously*

Motivation

Dave Rieken,
Vice President of
Research



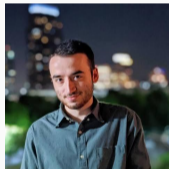
Sensor *placement* in
power systems is
wrong!

We have sensors
at **every node**:
The problem is
how we sense!

We make smart meters,
folks!

Here's an algorithm
that selects sensor
locations

**Samuel
Talkington**



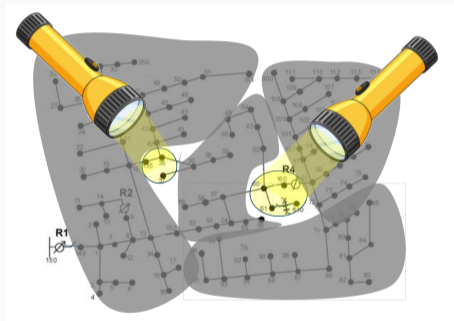
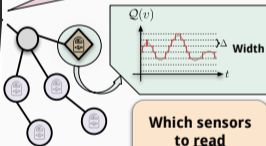
70% of North American households have smart meters, EIA, 2020.

Sensor placement-or sampling?

Dave Rieken,
Vice President of
Research



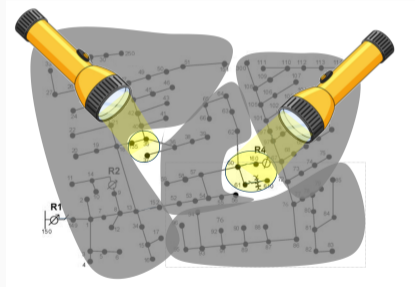
The key limitation is a
communication
bandwidth limit



70% of North American households have smart meters, EIA, 2020.

The problem

- Power distribution networks have high levels of sensors already, but with...
- *Limited communication **bandwidth**.*
- How do we **dynamically** monitor these sensor networks efficiently?
- **i.e., how to move these flashlights around?**



Power distribution systems

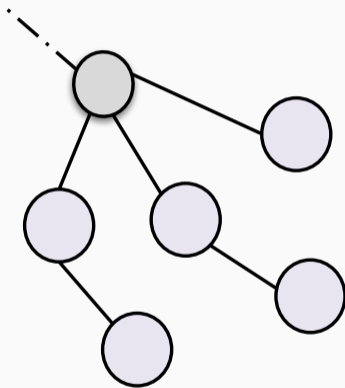


Figure 1: A distribution network can be modeled as a **tree network**, $|\mathcal{N}| = n$, and $|\mathcal{E}| = n - 1$.

Select only a few sensors

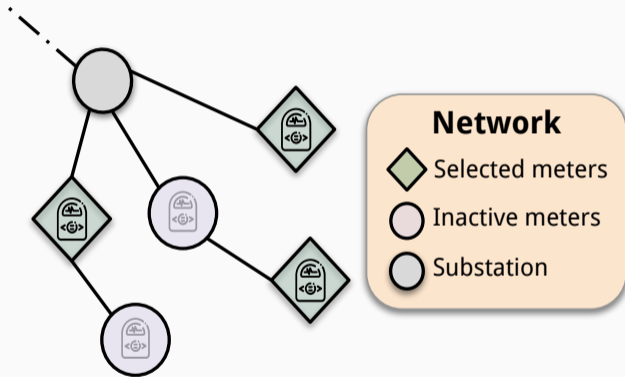


Figure 2: **Key idea:** we can only select a few sensors

Select \mathcal{S} , find worst case in \mathcal{S}

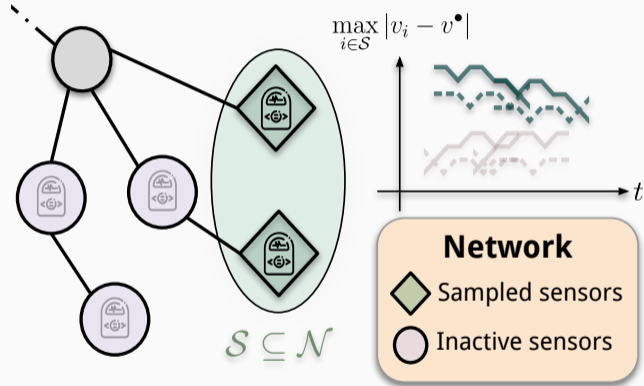


Figure 3: From \mathcal{S} , what's the **worst case** voltage?

Grid model

Power flow equations: Recap

- A grid is a **graph**: $\mathcal{G} = (\mathcal{N}, \mathcal{E})$, with $n = |\mathcal{N}|$ nodes.
- **Nodal voltages**: $\mathbf{u} = \mathbf{v} \circ \exp(j\boldsymbol{\theta}) \in \mathbb{C}^n$
 - $\mathbf{v} \in \mathbb{R}^n$ voltage magnitudes
 - $\boldsymbol{\theta} \in (-\pi, \pi]^n$ voltage phase angles
- **Nodal power injections**: $\mathbf{s} = \mathbf{p} + j\mathbf{q} \in \mathbb{C}^n$
 - $\mathbf{p} \in \mathbb{R}^n$, “active” power
 - $\mathbf{q} \in \mathbb{R}^n$, “reactive” power
- $\mathbf{Y} \in \mathbb{C}^{n \times n}$ nodal admittance matrix (generalized, complex-valued graph Laplacian)

Power flow equations $\mathbf{s} : \mathbb{C}^n \rightarrow \mathbb{C}^n$

$$\mathbf{s} = \text{diag}(\mathbf{u}) \mathbf{Y} \mathbf{u}$$

Linear power flow model

A simple power flow model is formed by inverting the power flow Jacobian at the flat start condition:

$$\begin{bmatrix} p \\ q \end{bmatrix} \approx \begin{bmatrix} G & -B \\ -B & -G \end{bmatrix} \begin{bmatrix} v - 1 \\ \theta \end{bmatrix} \Longleftrightarrow \begin{bmatrix} v - 1 \\ \theta \end{bmatrix} \approx \begin{bmatrix} R & X \\ X & -R \end{bmatrix} \begin{bmatrix} p \\ q \end{bmatrix}, \quad (1)$$

where $G, B \succeq 0$ are the real and imaginary components of the $n \times n$ reduced admittance matrix $Y = G + jB$, and $R, X \succeq 0$ are the *resistance and reactance* matrices.

Linear power flow model

For *distribution (tree) networks*, the voltage magnitudes $\mathbf{v} : \mathbb{R}^n \times \mathbb{R}^n \rightarrow \mathbb{R}^n$ can be approximated as a linear system:

$$\mathbf{v} \approx \mathbf{1} + \mathbf{R}\mathbf{p} + \mathbf{X}\mathbf{q}.$$

Linear distribution network model

Denoting $\epsilon := \mathbf{v} - \mathbf{1}$ as the *voltage magnitude perturbations*, we will analyze:

$$\epsilon = \mathbf{R}\mathbf{p} + \mathbf{X}\mathbf{q}.$$

Uncertain linear power flow model

Assumptions

Introduce generic uncertainty with the following assumptions:

- The reactive power injections q are set by a linear controller with a gain (ratio of reactive to active injections): $\kappa = q_i/p_i$, that is known for all nodes.
- The active power injections p are **random** with an **unknown distribution** with bounds $p_i \in [\underline{p}, \bar{p}]$ computed from historical data.

Key points about randomness in p :

- The uncertainty assumptions for p that are **neither Gaussian, independent, nor identically distributed**.
- Only requires **bounds**, which can be arise in engineering contexts such as:
 - Hosting capacity values.
 - Global horizontal irradiance (GHI) clear sky model data.
 - Device manufacturer limits.
 - Optimal power flow or other engineering constraints.

Main result

Theorem (Concentration of Voltages Under Uncertain Power Injections)

Let \mathbf{p} be an n -dimensional vector of random active power injections that are bounded between $\bar{\mathbf{p}}$ and $\underline{\mathbf{p}}$, and let $\Delta := \bar{\mathbf{p}} - \underline{\mathbf{p}}$ denote the bound width. Let \mathbf{K} be a fixed $n \times n$ control matrix such that $\mathbf{q} = \mathbf{K}\mathbf{p}$. Then $\mathbf{v} = \mathbf{1} + (\mathbf{R} + \mathbf{X}\mathbf{K})\mathbf{p}$, and perturbations in nodal voltages satisfy

$$\mathbb{E} [\|\mathbf{v} - \mathbf{1}\|_\infty] \leq \frac{1}{2} \Delta \|\mathbf{R} + \mathbf{X}\mathbf{K}\|_\infty \sqrt{2 \log(2n)}; \quad (2)$$

moreover, for any $t > 0$,

$$\Pr [\|\mathbf{v} - \mathbf{1}\|_\infty > t] \leq 2n \exp \left\{ \frac{-2t^2}{\Delta^2 \|\mathbf{R} + \mathbf{X}\mathbf{K}\|_\infty^2} \right\}. \quad (3)$$

Graph Fourier transform

From the fixed power factor assumption, there is an orthonormal $\mathbf{W} \in \mathbb{R}^{n \times n}$, specifically, a **graph Fourier basis**, such that $\psi := \mathbf{W}^T \epsilon$ is the *graph Fourier transform* of the voltage magnitudes. In summary,

$$\epsilon = \underbrace{(\mathbf{R} + \mathbf{X}\mathbf{K})}_{=\mathbf{L}^{-1}} \mathbf{p} = \mathbf{W}\mathbf{\Lambda}^{-1}\mathbf{W}^T \mathbf{p} = \mathbf{W}\psi \quad (4)$$

Benefit: There exist efficient algorithms for sampling sensors with this special structure (more on this later).

Spectral bandit algorithm outline

Strategy

At each time t : the learner picks b nodes to **check the security**.

The set of all strategies is the **set of all subsets of b nodes**.

$$\mathcal{A} = \{ \mathcal{S} \in 2^{\mathcal{N}} : |\mathcal{S}| \leq b \}, \quad (5)$$

so there are $|\mathcal{A}| = \binom{n}{b}$ possible strategies...challenging in general!

Reward

When the learner has selected sensors $\mathcal{S}_t \in \mathcal{A}$ to *ping*, she observes a *reward* $f : \mathcal{A} \rightarrow \mathbb{R}$ that looks like

$$\boxed{f(\mathcal{S}) = \text{Worst case voltage in } \mathcal{S}.} \quad (6)$$

In symbols:

$$f(\mathcal{S}) = \max_{i \in \mathcal{S}_t} |\epsilon_i| = \max_{i \in \mathcal{S}_t} |v_i - 1| = \max_{i \in \mathcal{S}_t} |\langle \mathbf{w}_i, \boldsymbol{\psi} \rangle|. \quad (7)$$

This reward is the **maximum voltage magnitude observed in the sampling strategy**.

How to catch a bandit

To pick the best sampling strategy, minimize the **regret**:

$$\text{Regret} = E [\text{Best voltage sampling strategy} - \text{Your voltage sampling strategy}]$$

If at first you don't succeed... try again!

Spectral bandit algorithm

Solution approach: At each timestep t , recursively compute an estimate of the *Fourier coefficients* ψ for the voltage magnitudes \mathbf{v} :

$$\hat{\psi}_t = \arg \min_{\psi \in \mathbb{R}^n} \sum_{s=1}^{t-1} (v_s - \langle \mathbf{w}_s, \psi \rangle)^2 + \beta \|\psi\|_{\Lambda}^2, \quad (8)$$

where $\beta > 0$ is a regularization parameter that you choose. The indices $s = 1, \dots, t-1$ are the **sampled nodes!**

Spectral regularization

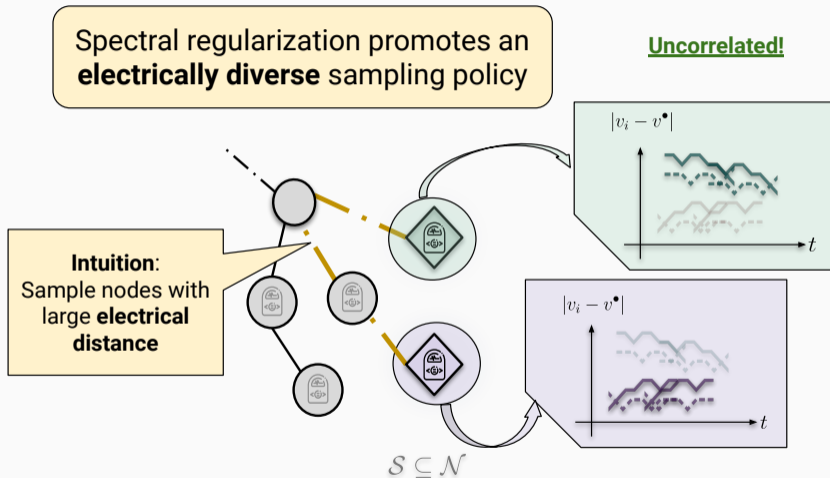
The regularization term, $\|\psi\|_{\mathbf{L}}$, promotes predictions of the voltages that are **electrically diverse**:

$$\|\psi\|_{\mathbf{L}} := \sqrt{\psi^{\top} \mathbf{L} \psi} = \sqrt{\sum_{(i,j) \in \mathcal{E}} y_{ij} (\psi_i - \psi_j)^2}. \quad (9)$$

This is also known as the **Dirichlet energy** of the graph.

Relates to *effective resistance*...check out the paper for more information

Intuition of spectral regularization



Bandit algorithm solution

The regression problem has a closed form solution at each timestep t :

$$\hat{\psi}_t = \left(\sum_{s=1}^{t-1} \mathbf{w}_s \mathbf{w}_s^T + \beta \mathbf{\Lambda} \right)^{-1} \left(\sum_{s=1}^{t-1} \mathbf{w}_s v_s \right) := \mathbf{V}_t^{-1} \left(\sum_{s=1}^{t-1} \mathbf{w}_s v_s \right).$$

Where $s = 1, \dots, t-1 \in \mathcal{N}$ are the **sampled nodes!** The voltage at one node is often similar to its neighbor.

Q: How do we pick those samples?

Answer: Need to **bridge the gap** between the signal processing technique (spectral bandits) and the structural concentration results.

How do we pick those sampled nodes?

Selecting the sample s for each time step:

- Given a sampling budget b , pick the top b nodes ranked by upper confidence bounds on the voltages
- Estimate $\hat{\psi}_t$
- Update **upper confidence bounds** (UCBs) for all nodes:

$$\text{UCB} = \underbrace{\left| \mathbf{w}_i^T \hat{\psi} - 1 \right|}_{\text{exploitation}} + c \underbrace{\|\mathbf{w}_i\|_{V_t^{-1}}}_{\text{exploration}}$$

The **exploration** term is determined by our concentration result (see the paper).

- Select the top b nodes greedily
- Continue on...

Extension to sampling strategies

Theorem (Concentration of voltage within sampling strategies)

Let $\mathcal{S} \subseteq \mathcal{N}$ be a sampling of b nodes. Suppose that $\Delta_t := \Delta$ for all t , and suppose that *LinDistFlow* accurately represents the network model. If the assumptions hold, we have

$$\mathbb{E} \left[\max_{i \in \mathcal{S}} |v_i - 1| \right] \lesssim \frac{1}{2} \Delta \max_{i \in \mathcal{S}} \left\| \mathbf{\Lambda}^{-1} \mathbf{w}_i \right\|_2^2 \sqrt{2 \log(b)}; \quad (10)$$

moreover, for all $\epsilon > 0$

$$\Pr \left[\max_{i \in \mathcal{S}} |v_i - 1| > \epsilon \right] \leq 2b \exp \left\{ \frac{-2\epsilon^2}{\Delta^2 \max_{i \in \mathcal{S}} \left\| \mathbf{\Lambda}^{-1} \mathbf{w}_i \right\|_2^2} \right\}. \quad (11)$$

Guaranteed performance

The regret of the sampler over m periods is bounded as

$$R_m \leq \tilde{O}(d\sqrt{m}), \quad (12)$$

where d is the **effective dimension** of the graph Laplacian:

$$d := \max_{i \in \mathcal{N}} i \quad \text{s.t.} \quad (i-1)\lambda_i \leq \frac{m}{\log(1 + m/\lambda_1)}, \quad (13)$$

where λ_1 is the smallest eigenvalue of L .

The optimal hyperparameter β depends on the effective dimension, the spectrum of the Laplacian. See our paper or^a for more.

^aT. Kocák, et al., "Spectral Bandits", Journal of Machine Learning Research, 21 (1), Jan. 2020.

Key take-away

Question: Why is this an improvement?

Answer: The worst case regret with standard least-squares is

$$R_m \leq \tilde{O}(n\sqrt{m}),$$

where n is the number of nodes. Our result, by **incorporating the graphical structure**¹ of the power flow equations,

$$R_m \leq \tilde{O}(d\sqrt{m}),$$

reduces the scaling factor to the *intrinsic dimension*, $d < n$, of the graph Laplacian.

(This is a huge improvement, as we will see empirically.)

¹T. Kocák, et al., "Spectral Bandits", Journal of Machine Learning Research, 21 (1), Jan. 2020.

New metric: AC regret

Limitations of traditional regret metric

- The traditional regret metric uses the **linear power flow approximation** as the “ground truth” for the best voltage sampling strategy
- Robust theoretical guarantees (more on this later), but not a good empirical metric due to lack of physical realism.
- The **AC power flow (ACPF)** provides a much more realistic model of the power flow equations (non-linear).

In the power system setting we can define the (empirical) metric we term **AC regret**:

$$\text{AC regret} = E [\text{Clairvoyant ACPF voltage sampling strategy} - \text{Your strategy}]$$

Note: Involves solving a non-linear estimation problem... no guarantees

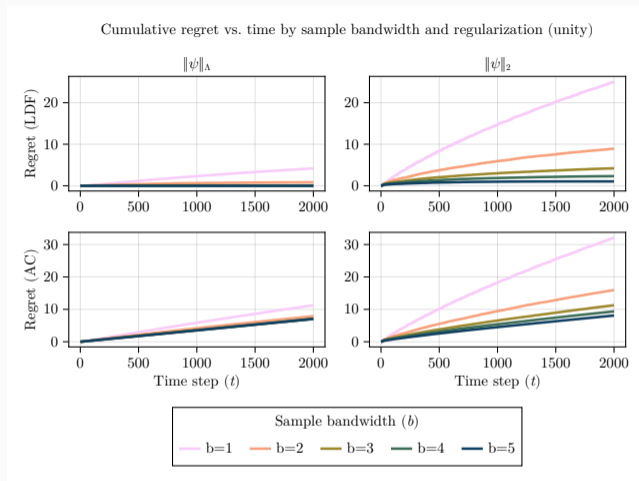


Figure 4: Fixed power factor: Regret of the bandwidth-constrained maximal voltage risk sampler vs. time with spectral (left) and ℓ_2 (right) regularization.

Additional empirical results for randomized control

We can relax the assumption on $\mathbf{q} = \mathbf{K}\mathbf{p}$, and let the entries of $\kappa_i := K_{ii}$ be random, e.g.,

$$\kappa_i \sim \text{Uniform}(\underline{\kappa}_i, \overline{\kappa}_i) \quad i = 1, \dots, n.$$

The following numerical results demonstrate that this works empirically, future work will generalize this.

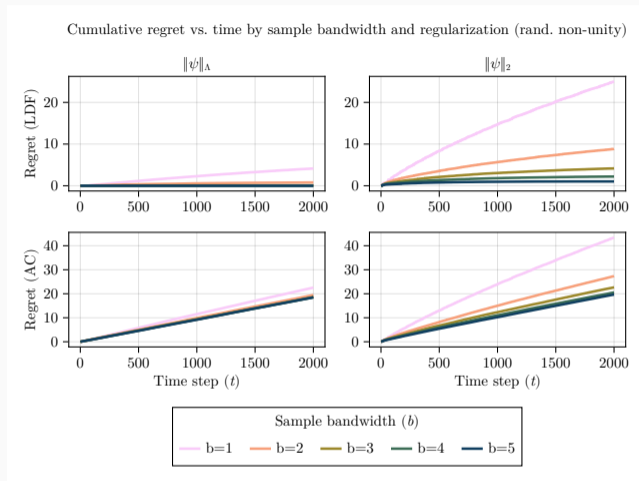


Figure 5: Non-fixed power factor: Regret of the bandwidth-constrained maximal voltage risk sampler vs. time with spectral (left) and ℓ_2 (right) regularization.

Thanks! Keep in touch: talkington@gatech.edu



This material is based upon work supported by the National Science Foundation Graduate Research Fellowship under Grant No. DGE-2039655. Any opinion, findings, and conclusions or recommendations expressed in this material are those of the authors(s) and do not necessarily reflect the views of the National Science Foundation.

30/30

Strategic distribution network sensing